



CHENMKO ENTERPRISE CO.,LTD

Halogens free devices

SURFACE MOUNT

PNP Multi-Chip General Purpose Amplifier

VOLTAGE 45 Volts CURRENT 0.1 Ampere

CHT857BVGP

APPLICATION

- * AF input stages and driver applicationon equipment.
- * Other general purpose applications.

FEATURE

- * Small surface mounting type. (SOT-563)
- * High current gain.
- * Suitable for high packing density.
- * Low collector-emitter saturation.
- * High saturation current capability.
- * Two internal isolated PNP transistors in one package.

CONSTRUCTION

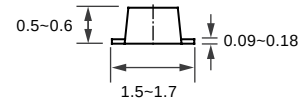
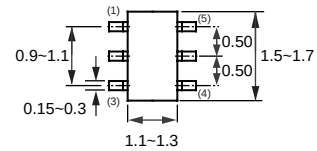
- * Two PNP transistors in one package.

MARKING

- * V4



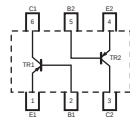
SOT-563



Dimensions in millimeters

SOT-563

CIRCUIT



LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS		UNIT
V_{CBO}	collector-base voltage	open emitter	-50	V
V_{CEO}	collector-emitter voltage	open base	-45	V
V_{EBO}	emitter-base voltage	open collector	-5	V
I_C	collector current (DC)		-0.1	A
P_C	Collector power dissipation		150	mW
T_{stg}	storage temperature		-55~+150	°C
T_j	junction temperature		+150	°C

Note

1. Transistor mounted on an FR4 printed-circuit board.

2004-07

RATING CHARACTERISTIC (CHT857BVGP)

THERMAL CHARACTERISTICS CHARACTERISTICS

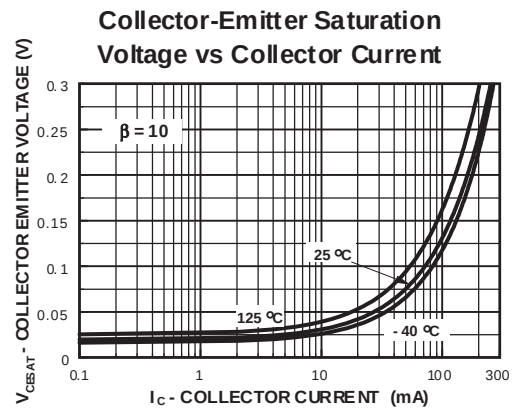
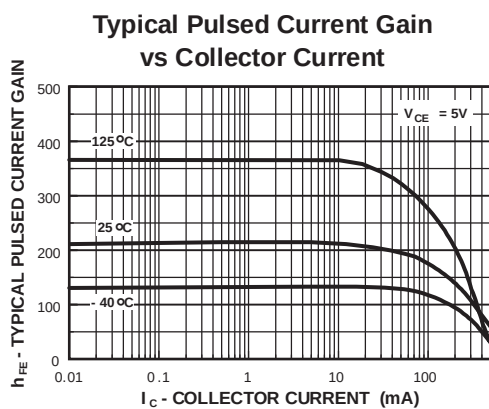
$T_{amb} = 25\text{ }^{\circ}\text{C}$ unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	Typ.	MAX.	UNIT
I_{CBO}	collector cut-off current	$I_E = 0; V_{CB} = -30\text{ V}$	–	–	-15	nA
		$I_C = 0; V_{CB} = -30\text{ V}; T_A = 150\text{ }^{\circ}\text{C}$	–	–	-5	μA
BV_{CBO}	collector-base breakdown voltage	$I_C = -10\text{ }\mu\text{A}$	-50	–	–	V
BV_{CEO}	collector-emitter breakdown voltage	$I_C = -10\text{ mA}$	-45	–	–	V
BV_{EBO}	emitter-base breakdown voltage	$I_E = -1\text{ }\mu\text{A}$	-5	–	–	V
h_{FE}	DC current transfer ratio	$V_{CE}/I_C = -5\text{ V}/-2\text{ mA}$	-200	–	-450	
V_{CEsat}	collector-emitter saturation voltage	$I_C = -10\text{ mA}; I_B = -0.5\text{ mA}$	–	–	-300	mV
		$I_C = -100\text{ mA}; I_B = -5\text{ mA}$	–	–	-650	mV
V_{BEsat}	base-emitter saturation voltage	$I_C = -10\text{ mA}; I_B = -0.5\text{ mA}$	–	-700	–	mV
C_{ib}	emitter input capacitance	$I_C = 0; V_{CB} = -0.5\text{ V}; f = 1\text{ MHz}$	–	8	–	pF
C_{ob}	collector output capacitance	$I_E = 0; V_{CB} = -10\text{ V}; f = 1\text{ MHz}$	–	3	–	pF
f_T	transition frequency	$I_E = -20\text{ mA}; V_{CE} = 5\text{ V}; f = 100\text{ MHz}$	–	200	–	MHz

Note

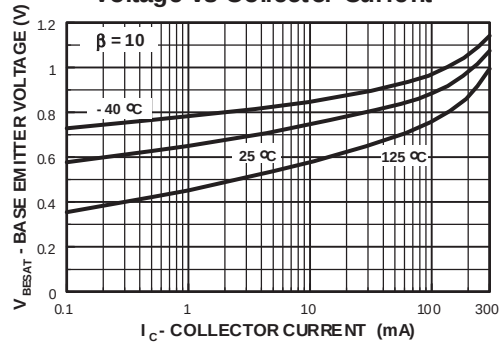
1. Pulse test: $t_p \leq 300\text{ }\mu\text{s}$; $\delta \leq 0.02$.

RATING CHARACTERISTIC CURVES (CHT857BVGP)

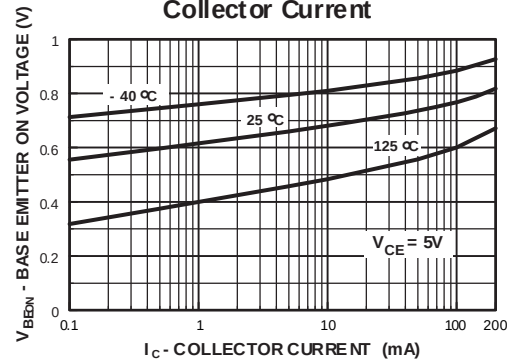


RATING CHARACTERISTIC CURVES (CHT857BVGP)

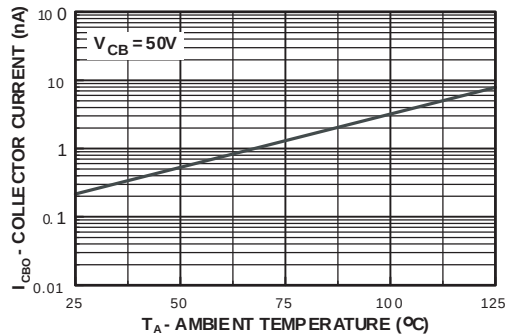
Base-Emitter Saturation
Voltage vs Collector Current



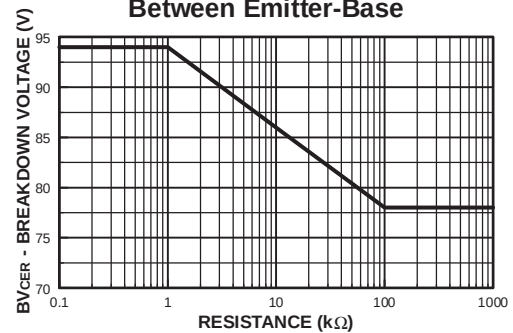
Base Emitter ON Voltage vs
Collector Current



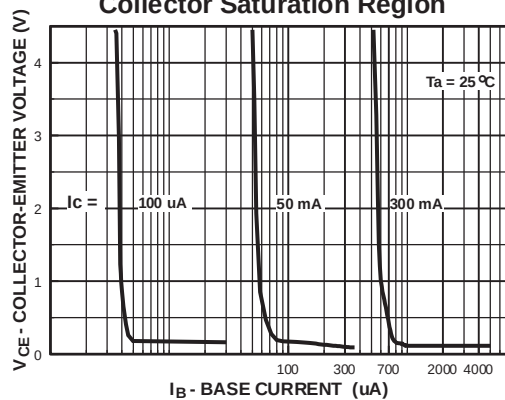
Collector-Cutoff Current
vs Ambient Temperature



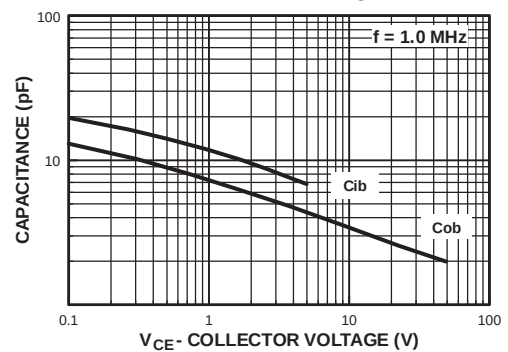
Collector-Emitter Breakdown
Voltage with Resistance
Between Emitter-Base



Collector Saturation Region



Input and Output Capacitance
vs Reverse Voltage



RATING CHARACTERISTIC CURVES (CHT857BVGP)

